

#### **Description**

The NVMFS5C466N uses advanced trench technology to provide excellent R<sub>DS(ON)</sub>, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

### **General Features**

 $V_{DS} = 40V I_{D} = 70A$ 

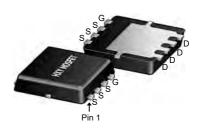
 $R_{DS(ON)}$  < 8.5m $\Omega$  @  $V_{GS}$ =10V

#### **Application**

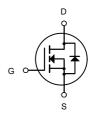
Battery protection

Load switch

Uninterruptible power supply



DFN5X6-8L (DFN-5(5.9x4.9))



N-Channel MOSFET

# **Package Marking and Ordering Information**

| Product ID  | Pack                      | Brand      | Qty(PCS) |
|-------------|---------------------------|------------|----------|
| NVMFS5C466N | DFN5X6-8L(DFN-5(5.9x4.9)) | HXY MOSFET | 5000     |

### Absolute Maximum Ratings (T<sub>C</sub>=25°C unless otherwise noted)

| Symbol                                | Parameter   | Rating                               | Units |  |
|---------------------------------------|---|--------------------------------------|-------|--|
| Vos                                   | Drain-Source Voltage  | 40                                   |       |  |
| Vgs                                   | Gate-Source Voltage ±20   |                                      |       |  |
| I <sub>D</sub> @T <sub>C</sub> =25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>    | А                                    |       |  |
| I <sub>D</sub> @T <sub>C</sub> =100°C | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>    | 44                                   | А     |  |
| Ідм                                   | Pulsed Drain Current <sup>2</sup>                               | 280                                  | А     |  |
| EAS                                   | Single Pulse Avalanche Energy <sup>3</sup>                      | 76                                   | mJ    |  |
| P <sub>D</sub> @T <sub>C</sub> =25°C  | Total Power Dissipation <sup>4</sup>                            | 72.3                                 | W     |  |
| Тѕтс                                  | Storage Temperature Range                                       | Storage Temperature Range -55 to 150 |       |  |
| TJ                                    | Operating Junction Temperature Range -55 to 150                 |                                      | °C    |  |
| Reja                                  | Thermal Resistance Junction-ambient (Steady State) <sup>1</sup> | 62                                   | °C/W  |  |
| Rejc                                  | Thermal Resistance Junction-Case <sup>1</sup> 1.73              |                                      | °C/W  |  |



## Electrical Characteristics (Ta=25°C, unless otherwise noted)

| Symbol              | Parameter                                      | Conditions  | Min.     | Тур. | Max. | Unit |  |
|---------------------|--|---|----------|------|------|------|--|
| BVDSS               | Drain-Source Breakdown Voltage                 | V <sub>GS</sub> =0V , I <sub>D</sub> =250uA                                     | 40       |      |      | V    |  |
| Rds(on)             |  | V <sub>GS</sub> =10V , I <sub>D</sub> =10A                                      | =10A 6.5 |      | 8.5  |      |  |
|                     | Static Drain-Source On-Resistance <sup>2</sup> | V <sub>GS</sub> =4.5V , I <sub>D</sub> =5A                                      |          | 10   | 15   | mΩ   |  |
| V <sub>GS(th)</sub> | Gate Threshold Voltage                         | Gate Threshold Voltage V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA |          | 1.7  | 3    | V    |  |
|                     | Drain-Source Leakage Current                   | V <sub>DS</sub> =32V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C               |          |      | 1    |      |  |
| IDSS                |  | V <sub>DS</sub> =32V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C               |          |      | 5    | uA   |  |
| Igss                | Gate-Source Leakage Current                    | V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V                                     |          |      | ±100 | nA   |  |
| gfs                 | Forward Transconductance                       | V <sub>DS</sub> =10V , I <sub>D</sub> =5A                                       |          | 13   |      | S    |  |
| Qg                  | Total Gate Charge (4.5V)                       |   |          | 20   |      |      |  |
| Qgs                 | Gate-Source Charge                             | V <sub>DS</sub> =20V , V <sub>GS</sub> =10V , I <sub>D</sub> =10A               |          | 2.8  |      | nC   |  |
| Qgd                 | Gate-Drain Charge                              |   |          | 5.1  |      |      |  |
| Td(on)              | Turn-On Delay Time                             |   |          | 13.2 |      |      |  |
| Tr                  | Rise Time                                      | V <sub>DD</sub> =15V , V <sub>GS</sub> =10V                                     |          | 2.2  |      | ns   |  |
| Td(off)             | Turn-Off Delay Time                            | R <sub>G</sub> =3.3 Ω   |          | 72   |      |      |  |
| T <sub>f</sub>      | Fall Time                                      | I <sub>D</sub> =1A  |          | 4.5  |      |      |  |
| Ciss                | Input Capacitance                              |   |          | 1278 |      |      |  |
| Coss                | Output Capacitance                             | V <sub>DS</sub> =25V , V <sub>GS</sub> =0V , f=1MHz                             |          | 135  |      | pF   |  |
| Crss                | Reverse Transfer Capacitance                   |   |          | 87   |      |      |  |
| ls                  | Continuous Source Current <sup>1,5</sup>       | V <sub>G</sub> =V <sub>D</sub> =0V , Force Current                              |          |      | 70   | Α    |  |
| VsD                 | Diode Forward Voltage <sup>2</sup>             | V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C                 |          |      | 1    | V    |  |

#### Note:

- 1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%.
- 3. The EAS data shows Max. rating . The test condition is  $V_{DD}=25V$ ,  $V_{GS}=10V$ , L=0.1mH,  $I_{AS}=47A$ .
- 4. The power dissipation is limited by 150°C junction temperature.
- 5. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.

# **Typical Characteristics**

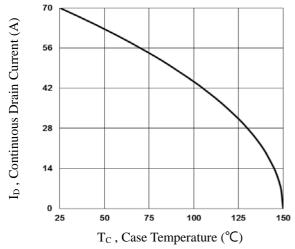


Fig.1 Continuous Drain Current vs. Tc

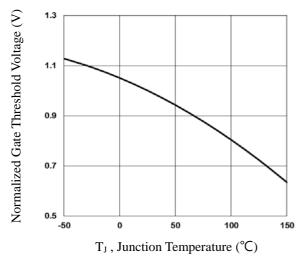


Fig.3 Normalized V<sub>th</sub> vs. T<sub>J</sub>

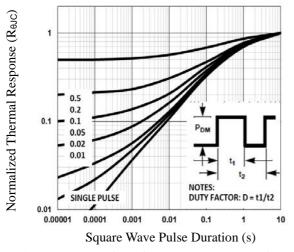


Fig.5 Normalized Transient Impedance

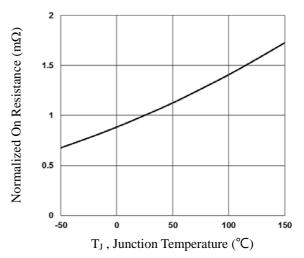


Fig. 2 Normalized RDSON vs. TJ

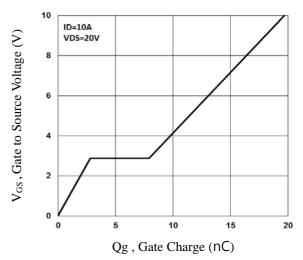


Fig. 4 Gate Charge Waveform

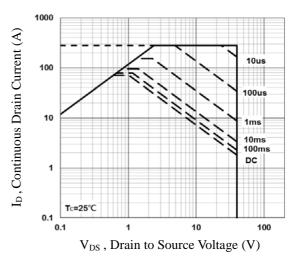


Fig.6 Maximum Safe Operation Area

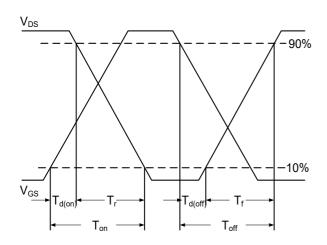


Fig.7 Switching Time Waveform

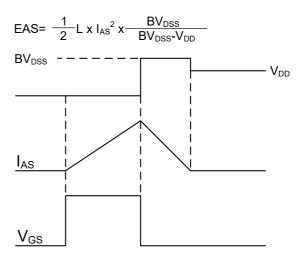
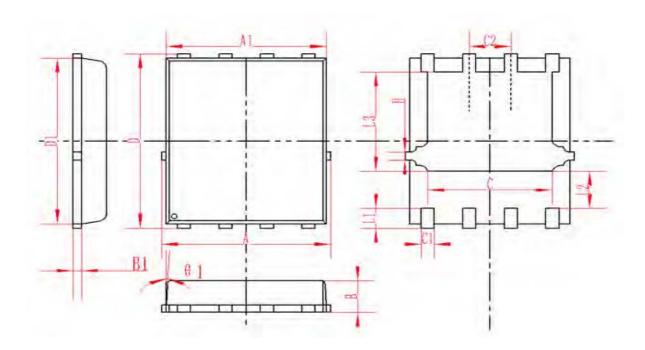


Fig.8 EAS Waveform



# DFN5X6-8L(DFN-5(5.9x4.9)) Package Information



| SYMBOL | MM       |         | INCH     |       |        |       |
|--------|----------|---------|----------|-------|--------|-------|
|        | MIN      | NOM     | MAX      | MIN   | NOM    | MAX   |
| Α      | 5.3      | 5.5     | 5.7      | 0.208 | 0.216  | 0.224 |
| A1     | 5.1      | 5.2     | 5.3      | 0.2   | 0.204  | 0.209 |
| D      | 5.98     | 6       | 6.02     | 0.235 | 0.236  | 0.237 |
| D1     | 5.85     | 6.05    | 6.25     | 0.23  | 0.238  | 0.246 |
| В      | 0.85     | 0.95    | 1.05     | 0.033 | 0.037  | 0.041 |
| B1     | 0.254REF |         | 0.010REF |       |        |       |
| С      | 3.95     | 4       | 4.05     | 0.156 | 0.157  | 0.159 |
| C1     | 0.35     | 0.4     | 0.45     | 0.014 | 0.016  | 0.018 |
| C2     |          | 1.27TYP |          |       | 0.5TYP |       |
| θ1     | 8°       | 10°     | 12°      | 8°    | 10°    | 12°   |
| L1     | 0.63     | 0.64    | 0.65     | 0.025 | 0.025  | 0.026 |
| L2     | 1.2      | 1.3     | 1.4      | 0.047 | 0.051  | 0.055 |
| L3     | 3.415    | 3.42    | 3.425    | 0.134 | 0.135  | 0.135 |
| Н      | 0.24     | 0.25    | 0.26     | 0.009 | 0.010  | 0.010 |



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